

Outline

- 1) Testing with nuisance parameters
- 2) UMPU multivariate tests
- 3) Conditioning on null sufficient stat

Nuisance Parameters

Common setup: Extra unknown parameters which are not of direct interest

$$\mathcal{P} = \left\{ P_{\theta, \lambda} : (\theta, \lambda) \in \Omega \right\}, H_0: \theta \in \Theta_0 \text{ vs } H_1: \theta \in \Theta_1$$

θ parameter of interest

λ nuisance parameter

Issue: λ unknown but might affect type I error or power of a given test

Ex $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, \sigma^2)$ $Y_1, \dots, Y_m \stackrel{iid}{\sim} N(\nu, \sigma^2)$
 μ, ν, σ^2 unknown

$$H_0: \mu = \nu \quad \text{vs} \quad H_1: \mu \neq \nu$$

$$\theta = \mu - \nu \quad \lambda = (\mu + \nu, \sigma^2) \quad \text{or} \quad (\mu, \sigma^2)$$

Ex $X_1 \sim \text{Binom}(n_1, \pi_1)$ $X_2 \sim \text{Binom}(n_2, \pi_2)$
 n_1, n_2 known \Rightarrow not nuisance parameters
 $H_0: \pi_1 \leq \pi_2 \quad \text{vs} \quad H_1: \pi_1 > \pi_2$

Multiparameter Exp. Families

Assume $X \sim p_{\theta, \lambda}(x) = e^{\theta^T t(x) + \lambda' u(x) - A(\theta, \lambda)} h(x)$

$\theta \in \mathbb{R}^s$, $\lambda \in \mathbb{R}^r$, both unknown.

How to test $H_0: \theta \in \Theta_0$ vs $H_1: \theta \in \Theta_1$?

Idea: Condition on $U(X)$ to eliminate dep. on λ

1) Sufficiency reduction:

$$(T(X), U(X)) \sim q_{\theta, \lambda}(t, u) \quad g dt du = \text{push-forward of } h du$$

$$= e^{\theta^T t + \lambda' u - A(\theta, \lambda)} g(t, u)$$

(density wrt e.g. Lebesgue on \mathbb{R}^{s+r})

2) Condition on $U(X)$:

$$q_\theta(t | u) = \frac{q_{\theta, \lambda}(t, u)}{\int q_{\theta, \lambda}(z, u) dz}$$

$$= \frac{e^{\theta^T t + \cancel{\lambda' u} - \cancel{A(\theta, \lambda)}}}{\int e^{\theta^T z + \cancel{\lambda' u} - \cancel{A(\theta, \lambda)}} g(z, u) dz} g(t, u)$$

$$= e^{\theta^T t - B_u(\theta)} g(t, u)$$

3) Conditional test:

Test $H_0: \Theta \in \Theta_0$ vs. $H_1: \Theta \in \Theta_1$, in

s-parameter model $\mathcal{Q}_n = \{q_{\theta}(t|u) : \Theta \in \Theta\}$

Note if $s=1$, this family has MLR in T

Even if $s > 1$, we still have gotten rid of λ

Theorem Let \mathcal{P} be full rank exp. fam. with

densities $P_{\theta,\lambda}(x) = e^{\theta T(x) + \lambda' U(x) - A(\theta, \lambda)}$ $h(x)$

$\theta \in \mathbb{R}$, $\lambda \in \mathbb{R}^r$, $(\theta, \lambda) \in \Omega$ open, Θ_0 possible

a) To test $H_0: \theta \leq \theta_0$ vs. $H_1: \theta > \theta_0$, there is a UMPU

test $\phi^*(x) = \chi(T(x); U(x))$ where

$$\chi(t; u) = \begin{cases} 1 & t > c(u) \\ \gamma(u) & t = c(u) \\ 0 & t < c(u) \end{cases}$$

with $c(u)$, $\gamma(u)$ chosen to make

$$E_{\theta_0} [\phi^*(x) | U(x)=u] = \alpha$$

b) To test $H_0: \theta = \theta_0$ vs. $H_1: \theta \neq \theta_0$ there is a UMPU

test $\phi^*(x) = \chi(T(x); U(x))$ where

$$\chi(t; u) = \begin{cases} 1 & t < c_1(u) \text{ or } t > c_2(u) \\ \gamma_i(u) & t = c_i(u) \\ 0 & t \in (c_1(u), c_2(u)) \end{cases}$$

with $c_i(u)$, $\gamma_i(u)$ chosen to make

$$E_{\theta_0} [\phi^*(x) | U(x)=u] = \alpha$$

$$E_{\theta_0} [T(x)(\phi^*(x)-\alpha) | U(x)=u] = 0$$

[Note λ has disappeared from the problem.]

$$\underline{\Sigma} X : \quad X_i \stackrel{\text{ind.}}{\sim} \text{Pois}(\mu_i) \quad i=1, 2$$

$$H_0: \mu_1 \leq \mu_2 \quad \text{vs.} \quad H_1: \mu_1 > \mu_2$$

$$p_{\mu}(x) = \prod_{i=1}^2 \frac{\mu_i^{x_i} e^{-\mu_i}}{x_i!}$$

$$= e^{X_1\gamma_1 + X_2\gamma_2 - (e^{\gamma_1} + e^{\gamma_2})} \frac{1}{x_1! x_2!}$$

(Where $\gamma_i = \log \mu_i$. $H_0: \gamma_1 \leq \gamma_2$ $H_1: \gamma_1 > \gamma_2$)

$$= e^{T(x) - \underbrace{\theta}_{X_1(\gamma_1 - \gamma_2)} + \underbrace{u(x)}_{(X_1+X_2)\gamma_2} - A(\gamma)} \frac{1}{x_1! x_2!}$$

$$H_0: \theta \leq 0 \quad \text{vs.} \quad H_1: \theta > 1$$

Reject for conditionally large values of

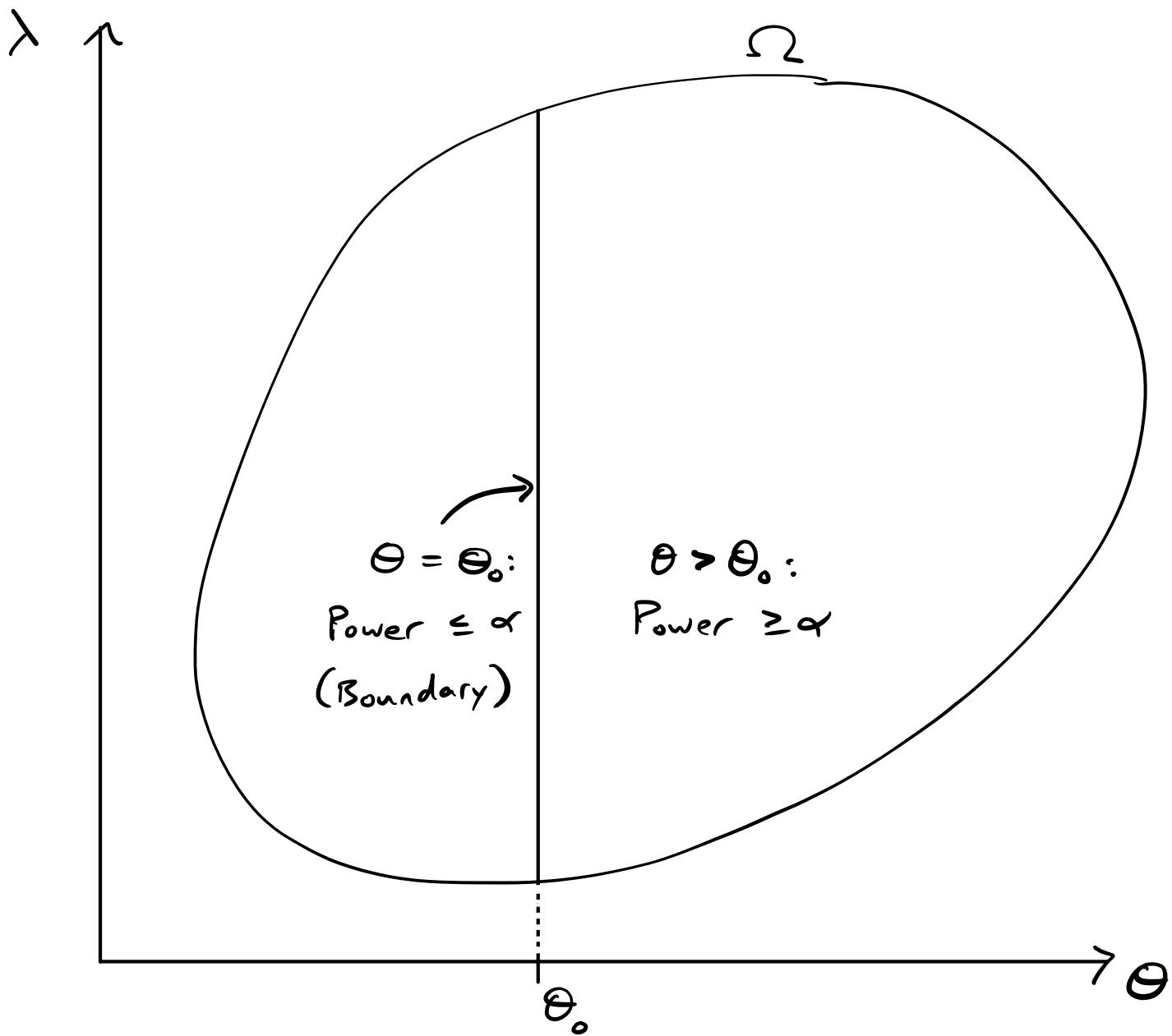
$$X_1, \text{ given } X_1 + X_2 = u$$

$$\begin{aligned} P_\theta(X_1=x_1 | U=u) &= e^{x_1\theta + u\lambda - A(\cdot)} \cdot \frac{1}{x_1!(u-x_1)!} \Bigg/ \sum_{x_1=0}^u (\cdot) \\ &\propto_{x_1} e^{x_1\theta} \cdot \frac{u!}{x_1!(u-x_1)!} \\ &= \text{Binom}\left(u, \frac{e^\theta}{1+e^\theta}\right) \quad e^\theta = \mu_1/\mu_2 \end{aligned}$$

$$= \text{Binom}\left(u, \frac{\mu_1}{\mu_1+\mu_2}\right)$$

So in the end we do a Binomial test.

Proof Sketch



- 1) Any unbiased test has $\beta(\Theta_0, \lambda) = \alpha \quad \forall \lambda$
(continuity of $\beta(\theta, \lambda)$)
- 2) Power $\equiv \alpha$ on boundary $\Rightarrow E_{\Theta_0}[\phi | u] \stackrel{a.s.}{=} \alpha$
($u(x)$ complete sufficient on boundary submodel)
- 3) ϕ^* optimal among all tests with conditional level α
(by reduction to univariate model)

Proof

Assume ϕ any unbiased test

$$\underline{\text{Step 1:}} \quad \mathbb{E}_{\theta, \lambda} |\phi(x)| \leq 1 < \infty \quad \forall (\theta, \lambda) \in \Omega$$

(Keener Thm 2.4)
 $\Rightarrow \mathbb{E}_{\theta, \lambda} \phi(x)$ infinitely diff. on Ω , can diff. under \int

$$\phi \text{ unbiased} \Rightarrow \mathbb{E}_{\theta_0, \lambda} [\phi(x)] = \alpha \quad \forall (\theta_0, \lambda) \in \Omega$$

$$\underline{\text{Step 2:}} \text{ Boundary submodel: } \mathcal{P}_{\theta_0} = \{ P_{\theta_0, \lambda} : (\theta_0, \lambda) \in \Omega \}$$

$$P_{\theta_0, \lambda}(x) = e^{\lambda' U(x) - A(\theta_0, \lambda)} \cdot \frac{e^{\theta_0 T(x)}}{h(x)}$$

\mathcal{P}_{θ_0} is full-rank, s-param exp. fam., $U(x)$ comp. suff.

$$\text{Let } f(u) = \mathbb{E}_{\theta_0} [\phi(x) | U(x) = u] - \alpha$$

$$\mathbb{E}_{\theta_0, \lambda} [f(U(x))] = \mathbb{E}_{\theta_0, \lambda} [\phi(x)] - \alpha = 0 \quad \forall \lambda$$

$$\Rightarrow f(u) \stackrel{a.s.}{=} 0$$

$$\Rightarrow \mathbb{E}_{\theta_0} [\phi(x) | U(x) = u] = 0 \quad \forall u$$

$$\underline{\text{Two-sided case:}} \quad g(u) = \frac{d}{d\theta} \mathbb{E}_{\theta_0} [\phi | U=u]$$

$$= \mathbb{E}_{\theta_0} [(T - \mathbb{E}_{\theta_0} [\tau | u]) \phi | u]$$

$$= \mathbb{E}_{\theta_0} [\tau (\phi - \alpha) | u]$$

$$\mathbb{E}_{\theta_0, \lambda} g(u) = \mathbb{E}_{\theta_0, \lambda} [\tau (\phi - \alpha)] = \frac{\partial}{\partial \theta} B_\phi(\theta_0) = 0 \quad \forall \lambda$$

$$\Rightarrow \frac{d}{d\theta} \mathbb{E}_{\theta_0} [\phi | u] \stackrel{a.s.}{=} 0 \quad (\text{Cond'l power has derivative 0 at } \theta_0)$$

Step 3: For any value u , the conditional model is

$$g_\theta(t|u) = e^{\theta t - Bu(\theta)} g(t,u), \text{ 1-param. exp. fam}$$

In one- / two-sided case, we have shown

$\psi(t;u)$ is UMP / UMPU in \mathcal{Q}_u

Let $\bar{\phi}(t;u) = \mathbb{E}[\phi(x) | T(x)=t, u(x)=u]$

$$\begin{aligned}\mathbb{E}_\theta[\bar{\phi}(T;u) | u=u] &= \mathbb{E}_\theta[\phi(x) | u(x)=u] \\ &= \alpha \text{ if } \theta = \theta_0\end{aligned}$$

$\Rightarrow \bar{\phi}(\cdot;u)$ is a (cond.'l) test of H_0 vs. H_1
in \mathcal{Q}_u with power = α at boundary

One-sided case:

(or $\theta \leq \theta_0$)

$\psi(t;u)$ is the UMP test of $\theta = \theta_0$ vs $\theta > \theta_0$
in \mathcal{Q}_u , which is a 1-param. exp. fam.

Two-sided case:

$\psi(t;u)$ is the UMP test of $\theta = \theta_0$ vs. $\theta \neq \theta_0$
among tests with power = α , $\frac{d}{d\theta}$ power = 0 @ θ_0

In either case ψ has higher cond. power
than $\bar{\phi}$, a.s.

For $(\theta, \lambda) \in \Omega_1$:

$$\begin{aligned} \mathbb{E}_{\theta, \lambda}[\phi(x)] &= \mathbb{E}_{\theta, \lambda} \left[\mathbb{E}_\theta [\bar{\phi}(\tau; u) | u] \right] \\ &\leq \mathbb{E}_{\theta, \lambda} \left[\mathbb{E}_\theta [\psi(\tau; u) | u] \right] \\ &= \mathbb{E}_{\theta, \lambda}[\phi^*(x)] \end{aligned}$$

\underline{E}_X $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, \sigma^2)$ $\sigma^2 > 0$ unknown

$H_0: \mu = 0$ vs. $H_1: \mu \neq 0$

$$\rho_{\mu, \sigma^2}(x) = e^{\frac{\mu}{\sigma^2} \sum X_i - \frac{1}{2\sigma^2} \sum X_i^2 - \frac{n\mu}{2\sigma^2}} \cdot \left(\frac{1}{2\pi\sigma^2} \right)^{n/2}$$

Θ $\underbrace{T = \bar{X}}$ λ $\underbrace{u = \|X\|^2}$

Optimal test rejects when \bar{X} is extreme given $\|X\|^2$

If $\mu = 0$, ρ is rotationally symmetric

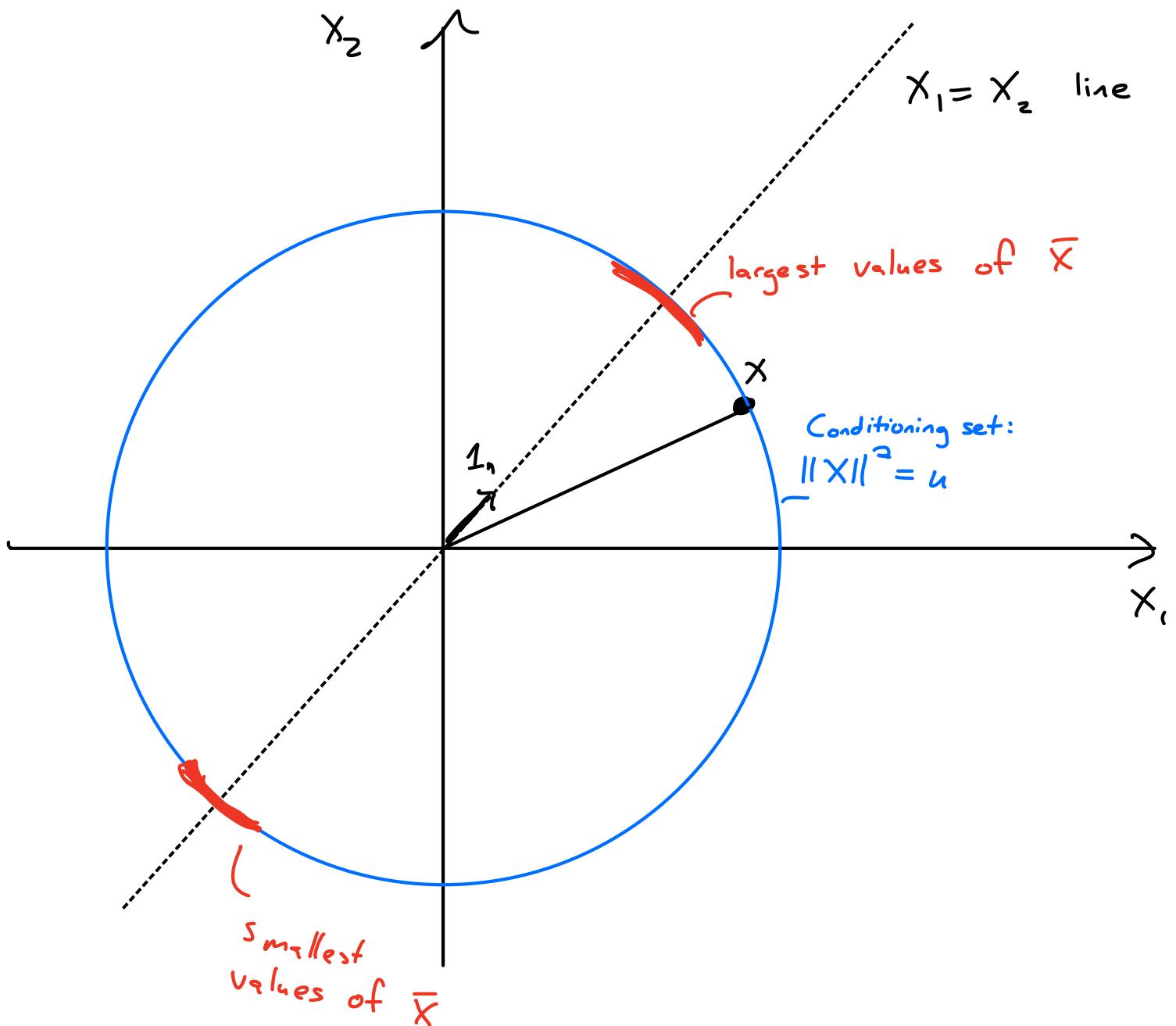
$$\Rightarrow X / \|X\|^2 \stackrel{H_0}{\sim} \text{Unif}(\mathbb{S}^{n-1})$$

$$(\Leftrightarrow \frac{X}{\|X\|} \stackrel{H_0}{\sim} \text{Unif}(\mathbb{S}^{n-1}), \text{ indep. of } \|X\|)$$

Optimal test rejects when $\frac{\bar{X}}{\|X\|}$ extreme (marginally)

Could stop here & simulate

Geometric Picture ($n=2$)



t - statistic

Above test rejects for

- conditionally extreme \bar{X} given $\|X\|^2$

- OR
- marginally extreme $\frac{\bar{X}}{\|X\|}$ ($\perp \parallel \|X\|^2$)

(equiv.)

Equivalent: reject for marginally extreme

$$T = \frac{\sqrt{n} \bar{X}}{\sqrt{S^2}}, \text{ where}$$

$$S^2 = \frac{1}{n-1} \sum (x_i - \bar{x})^2 \quad (\text{sample variance})$$

$$= \frac{1}{n-1} \left(\sum x_i^2 - 2\bar{x} \sum x_i + n\bar{x}^2 \right)$$

$$= \frac{1}{n-1} \left(\|X\|^2 - n\bar{x}^2 \right)$$

$$r \rightarrow \frac{r}{\sqrt{1-r^2}} : \quad \begin{array}{c} r \\ \diagdown \\ 1-r^2 \end{array}$$

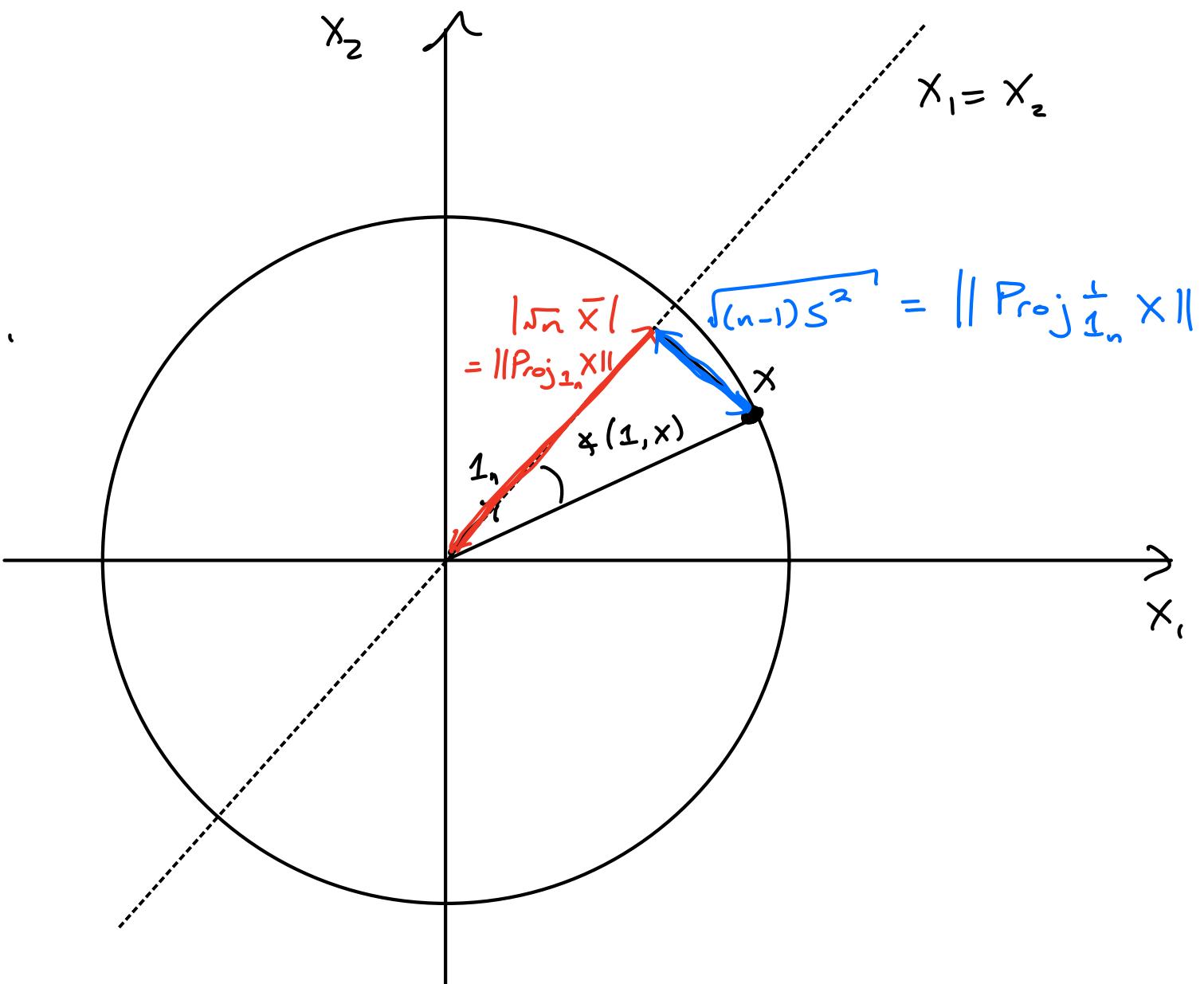
$$\Rightarrow T = \sqrt{n-1} \cdot \frac{\sqrt{n} \bar{X}}{\sqrt{\|X\|^2 - n\bar{x}^2}} = \sqrt{n-1} \cdot \frac{\bar{X}}{\sqrt{1-R^2}}$$

for $R = \frac{\sqrt{n} \bar{X}}{\|X\|} = \underbrace{\frac{1}{\sqrt{n}} \mathbf{1}_n^\top}_{\text{unit vectors}} \underbrace{\frac{X}{\|X\|}}_{\text{unit vector}}$ $= \cos \varphi(\mathbf{1}_n, X)$

$$f\left(\frac{X}{\|X\|}\right) \Rightarrow \perp \parallel \|X\|$$

Geometric Picture

$$T = \frac{\sqrt{n} \bar{X}}{\sqrt{s^2}} = \frac{\|\text{Proj}_{\mathbb{1}_n} X\|}{\|\text{Proj}_{\mathbb{1}_n^\perp} X\|} \cdot \sqrt{n-1} \operatorname{sgn}(\bar{x})$$



Next major theme: ratios of projections

Permutation Tests

Even if we don't get a UMPU test at the end, conditioning on null suff. stat. still helps.

Ex. $X_1, \dots, X_n \stackrel{iid}{\sim} P$ $Y_1, \dots, Y_m \stackrel{iid}{\sim} Q$ $H_0: P = Q$ $H_1: P \neq Q$

Under H_0 , $P = Q$, $X_1, \dots, X_n, Y_1, \dots, Y_m \stackrel{iid}{\sim} P$

Let $(Z_1, \dots, Z_{n+m}) = (X_1, \dots, X_n, Y_1, \dots, Y_m)$

Under H_0 , $U(Z) = (Z_{(1)}, \dots, Z_{(n+m)})$ compl. suff

Let $S_{n+m} = \{\text{Permutations on } n+m \text{ elements}\}$

$(x, y) | u \stackrel{H_0}{\sim} \text{Unif}(\{\pi u : \pi \in S_{n+m}\})$

Thus, for any test stat T , if $P = Q$,

$$P_{P, Q}(T(Z) \geq t | u) = \frac{1}{(n+m)!} \sum_{\pi \in S_{n+m}} \mathbb{I}\{T(\pi z) \geq t\}$$

Monte Carlo test: In practice, we sample

$\pi_1, \dots, \pi_B \stackrel{iid}{\sim} S_{n+m}$, e.g. $B = 1000$

Then $Z, \pi_1 z, \dots, \pi_B z \stackrel{iid}{\sim} \text{Unif}(S_{n+m} u)$ under H_0

$$\text{MC p-value } p = \frac{1}{1+B} \left(1 + \sum_{b=1}^B \mathbb{I}\{T(z) \leq T(\pi_b z)\} \right)$$

$$\stackrel{H_0}{\sim} \text{Unif}\left(\left\{\frac{1}{1+B}, \dots, \frac{B-1}{1+B}, 1\right\}\right) \quad (\text{if no ties})$$

$(p \geq \text{Unif}(\cdot) \text{ if there are ties})$